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Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Complete if Known			
		Application Number	09/862,356		
		Filing Date	May 22, 2001		
		First Named Inventor	Steve Tendon		
		Art Unit	2161		
		Examiner Name	Not Yet Assigned		
Sheet	1	of	1	Attorney Docket Number	ALBIHN-410

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U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
DL	A	US-5,774,870-	06-30-1998	Storey	
DL	B	US-5,983,196-	11-09-1999	Wendkos	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	†
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OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ²
DL	C	Martin Fowler, "Analysis Patterns", Addison-Wesley, Reading, MA, 1977, pp. 95-155			✓
DL	D	Enrich Gamma, et al., "Design Patterns", Addison-Wesley, Reading, MA, 1995, pp. 175-185			✓

Examiner Signature		Date Considered	12/3/05
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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